

Precision full-wave signal rectifier needs no diodes

José M Blanes and José A Carrasco,
University Miguel Hernández, Elche, Spain

Rectifier circuits based on semiconductor diodes typically handle voltage levels that greatly exceed the diodes' forward-voltage drops,

which generally don't affect the accuracy of the rectification process. However, the rectified signal's accuracy suffers when the diode's voltage drop ex-

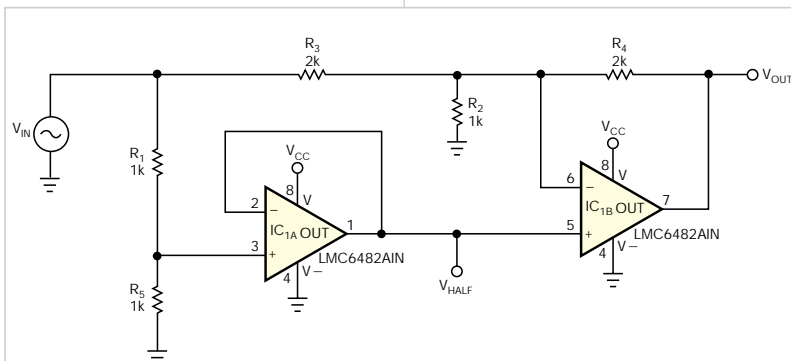


Figure 1 This precision full-wave-rectifier circuit uses two op amps and no diodes. When altering the basic design, note that resistors R_3 and R_4 are both twice the value of R_2 and that R_1 and R_5 are equal.

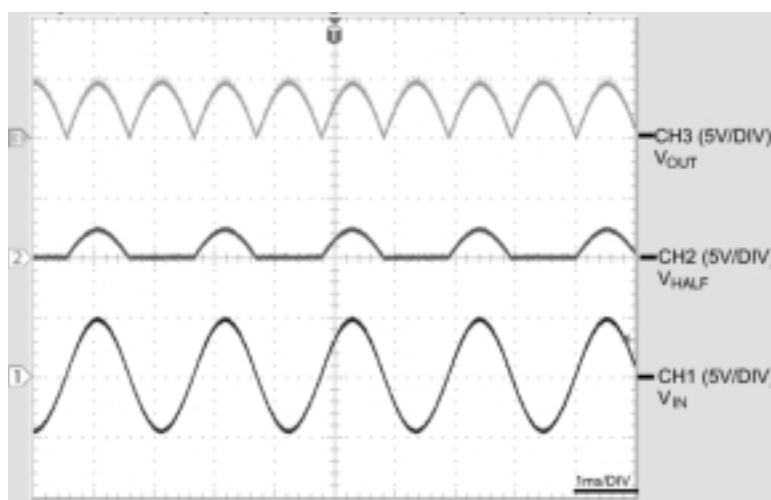


Figure 2 From bottom to top, the waveforms show V_{IN} (CH1), V_{HALF} (CH2), and V_{OUT} (CH3).

DIs Inside

82 1-Hz to 100-MHz VFC features
160-dB dynamic range

86 Cascode MOSFET increases
boost regulator's input- and
output-voltage ranges

ceeds the applied voltage. Precision rectifier circuits combine diodes and operational amplifiers to eliminate the effects of diode voltage drops and enable high-accuracy, small-signal rectification. By taking advantage of modern operational amplifiers that can handle rail-to-rail inputs and outputs, the circuit in **Figure 1** dispenses with diodes altogether, provides full-wave rectification, and operates from a single power supply.

The circuit operates as follows: If $V_{IN} > 0V$, then IC_{1A} 's output, V_{HALF} , equals $V_{IN}/2$, and IC_{1B} operates as a subtractor, delivering an output voltage, V_{OUT} , equals V_{IN} . In effect, the circuit operates as a unity-gain follower. If $V_{IN} < 0V$, then $V_{HALF} = 0V$, and the circuit behaves as a unity-gain inverter and delivers an output of $V_{OUT} = -V_{IN}$. **Figure 2** shows the circuit's input signal at V_{IN} ; its intermediate voltage, V_{HALF} ; and its output voltage, V_{OUT} .

The circuit uses a single National Semiconductor LMC6482 chip and operates in the linear regions of both operational amplifiers. Suggested applications include low-cost rectification for automatic gain control, signal demodulation, and process instrumentation. The circuit relies on only one device-dependent property: The amplifiers must not introduce phase inversion when the input voltage exceeds the negative power supply; the LMC6482 meets this requirement. **EDN**

1-Hz to 100-MHz VFC features 160-dB dynamic range

Jim Williams, Linear Technology Corp

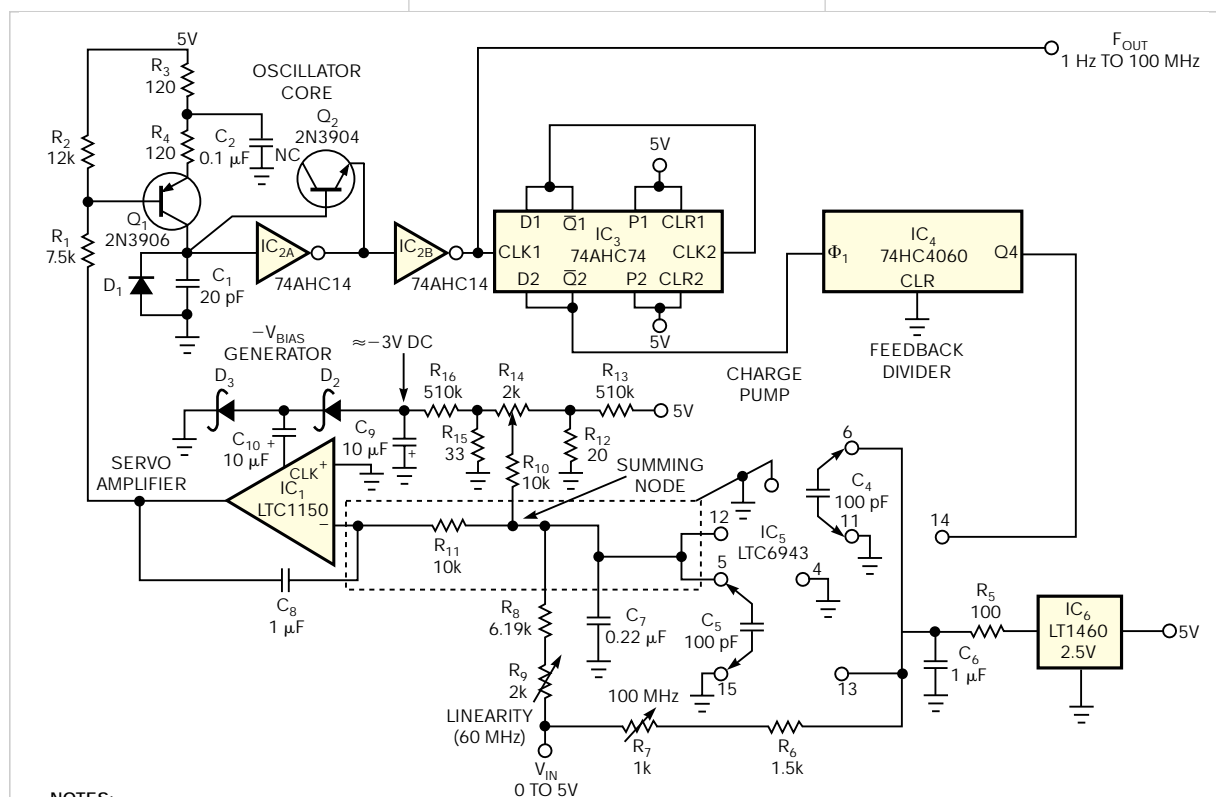
The VFC (voltage-to-frequency-converter) circuit in **Figure 1** achieves a wider dynamic range and a higher full-scale output frequency—100 MHz with 10% overrange to 110 MHz—by a factor of 10 over any commercially available converter. The circuit's 160-dB dynamic range spans eight decades for a 0 to 5V input range and allows continuous operation down to 1 Hz. Additional specifications include 0.1% linearity, a 250-ppm/°C

gain/temperature coefficient, a 1-Hz/°C zero-point shift, and a 0.1% frequency shift for a 10% power-supply-voltage variation. A single 5V supply powers the circuit.

Chopper-stabilized amplifier IC₁, an LTC-1150, controls a crude but wide-range oscillator core comprising bipolar transistors Q₁ and Q₂ and inverters IC_{2A} and IC_{2B}. In addition to delivering a logic-level output, the oscillator core clocks divide-by-four counter IC₃,

which in turn drives IC₄, a 74HC4060 configured as a divide-by-16 counter.

After undergoing a total division by 64 in IC₃ and IC₄, the oscillator core's output drives a charge pump comprising IC₅, an LTC6943, and its associated components. The averaged difference between the charge pump's output and the applied input voltage appears at the summing node and biases IC₁, thereby closing the control loop around the wide-range oscillator core.



NOTES:

1. D₁: JPAD-500, D₂, D₃: BAT-85, R₅, R₆, R₈: TRW-IRC TYPE MAR-6, 1% METAL-FILM, C₄, C₅: WIMA TYPE FKP-2 CAPACITORS, AND C₇, C₈: WIMA TYPE MKS-2 CAPACITORS.
2. CONNECT ALL COMPONENTS AT Q₁'S COLLECTOR WITH A MINIMUM-AREA AIR-INSULATED "FLOATING" JUNCTION OVER A RELIEVED AREA OF GROUND TO MINIMIZE STRAY CAPACITANCE.
3. ENCLOSE R₁₁ AND ITS CONNECTIONS TO R₉, R₁₀, IC₁'S INVERTING INPUT, C₇, AND PINS 5 AND 12 OF IC₅ WITHIN SOLDER- AND COMPONENT-SIDE GUARD TRACES TO INTERCEPT ANY BOARD-SURFACE LEAKAGE CURRENTS. (NOTE THAT THE DASHED LINE DEFINES THE GUARD TRACE.)
4. CONNECT IC₂'S UNUSED INPUTS TO GROUND. THE SCHEMATIC OMITS POWER-SUPPLY CONNECTIONS TO MOST ICs FOR CLARITY

Figure 1 Featuring a 160-dB dynamic range corresponding to a 1-Hz- to 100-MHz-frequency span, this voltage-to-frequency converter operates from a single 5V power supply.

The circuit's extraordinary dynamic range and high speed derive from the oscillator core's characteristics, the divider/charge-pump-based feedback loop, and IC₁'s low dc input errors. Both IC₁ and IC₅ help stabilize the circuit's operating point by contributing to overall linearity and stability. In addition, IC₁'s low offset drift ensures the circuit's 50-nV/Hz gain-versus-frequency characteristic slope and permits operation as low as 1 Hz at 25°C.

Applying a positive input voltage causes IC₁'s output to go negative and alter Q₁'s bias. In turn, Q₁'s collector current produces a voltage ramp on C₁ (upper trace in **Figure 2**). The ramp's amplitude increases until Schmitt trigger inverter IC_{2A}'s output (lower trace in **Figure 2**) goes low, discharging C₁ through Q₂ (connected as a low-leakage diode). Discharging C₁ resets IC_{1A}'s output to its high state, and the ramp-and-reset action continues.

The leakage current of diode D₁, a Linear Systems JPAD-500, dominates all other parasitic currents in the oscillator core, but its 500-pA maximum leakage ensures operation as low as 1 Hz. The two sections of charge pump IC₅ operate out of phase and transfer charge at each clock transition. Components critical to the charge pump's stability include a 2.5V LT-1460 voltage reference, IC₆; two Wima FKP-2 polypropylene film/foils; 100-pF capacitors, C₄ and C₅; and the low charge-injection characteristics of IC₅'s internal switches.

The 0.22-μF capacitor, C₇, averages the difference signal between the input-derived current and the charge pump's output and applies the smoothed dc signal to amplifier IC₁, which in turn controls the bias applied to Q₁ and thus the circuit's operating point. As noted, the circuit's closed-loop-servo action reduces the oscillator's drift and enhances its high linearity. A 1-μF Wima MKS-2 metallized-film-construction capacitor, C₈, compensates the servo loop's frequency response and ensures stability. **Figure 3** illustrates the loop's well-behaved response (lower trace) to an input-voltage step (upper trace).

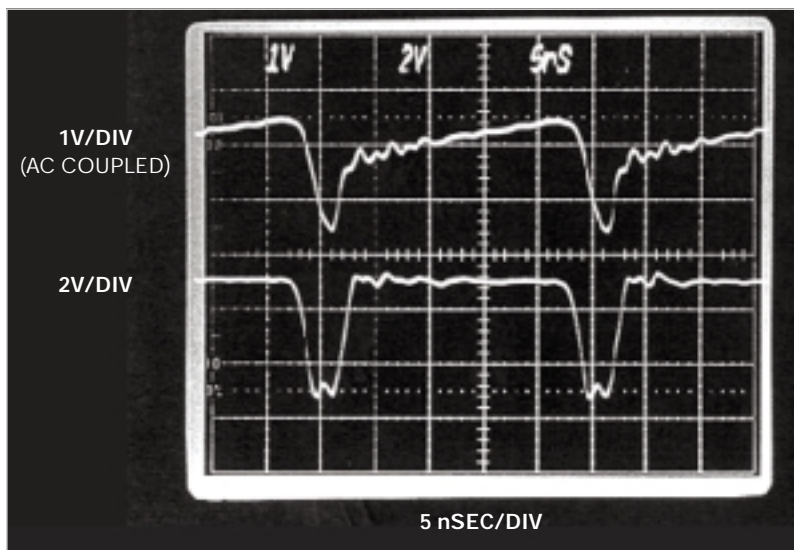


Figure 2 On a 700-MHz real-time oscilloscope, the oscillator-core waveforms at a 40-MHz operating frequency show the ramp-and-reset waveform at Q₁'s collector (upper trace) and Q₂'s emitter (lower trace).

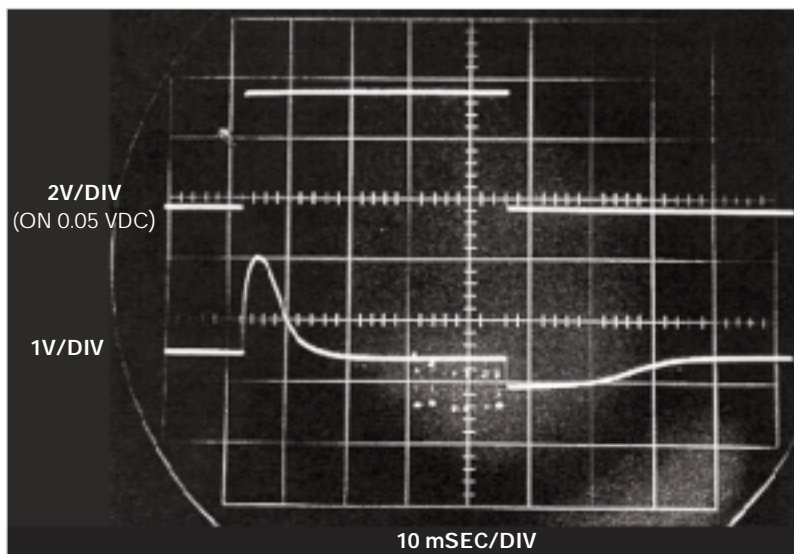


Figure 3 In response to an input-voltage step (upper trace), the voltage at the circuit's summing junction shows a 30-msec settling time.

For the circuit to achieve its design goals, certain special techniques and considerations apply. Diode D₁'s leakage current dominates all other parasitic leakage currents at IC_{2A}'s input, and thus Q₁ must always supply sufficient source current to sustain oscillation and ensure operation as low as 1 Hz.

The circuit's 100-MHz full-scale

upper frequency limit forces stringent restrictions on the oscillator core's cycle time, and only 10 nsec is available for a complete ramp-and-reset sequence. The reset interval imposes an ultimate speed limit on the circuit, but the upper trace in **Figure 2** shows a 6-nsec reset interval that falls comfortably within the 10-nsec limit. A path from the cir-

cuit's input to the charge pump's output allows for correction of small nonlinearities due to residual charge injection. This input-derived correction is effective because the charge injection's effects vary directly with the oscillation frequency, which the input voltage determines.

Although you can use the component values given in **Figure 1** to assem-

ble prototypes and small production quantities of the circuit, you need to consider component selection for optimum manufacturability and high-volume production. **Table 1** lists certain components' target values and estimated selection yields. The notes in **Figure 1** list the key components that the design uses.

To calibrate the circuit, apply 5V to

the input and adjust the 100-MHz trimmer, R_7 , for a 100-MHz output. Next, connect the input to ground and adjust trimmer R_{13} for a 1-Hz output. Allow for an extended settling interval because, at this frequency, the charge-pump update occurs once every 32 sec. Note that R_{13} 's adjustment range accommodates either a positive or a negative offset voltage because IC_1 's clock output generates a negative bias voltage for R_{13} . Next, apply 3V to the input and adjust R_9 for a 60-MHz output. A certain amount of interaction occurs among the adjustments, so repeat the process until you arrive at optimum values for the three calibration frequencies.^{EDN}

TABLE 1 SELECTION CRITERIA FOR COMPONENTS		
Component	Selection parameter at 25°C	Typical yield (%)
Q_1	$I_{CER} < 20 \text{ pA at } 3V$	90
Q_2	$I_{EBO} < 20 \text{ pA at } 3V$	90
D_1	$75 \text{ pA at } 3V; I_{REV} < 500 \text{ pA}$	80
IC_{2A}	$I_{IN} < 25 \text{ pA}$	80
IC_1	$I_b < 5 \text{ pA at } V_{CC} = 5V$	90
IC_{2A}, IC_{2B}	Must toggle with 3.6-nsec-wide (at-50%-level) input pulse	80

Cascode MOSFET increases boost regulator's input- and output-voltage ranges

Scot Lester, Texas Instruments, Dallas, TX

Targeting use in portable-system applications that require raising a battery's voltage to a higher level, IC boost regulators often include output transistors that can drive storage inductors. However, most boost regulators' absolute-maximum input-voltage rating typically doesn't exceed 6V, an adequate level for battery operation. In addition, breakdown voltage of the regulator's output transistor limits the regulator's absolute-maximum output voltage to 25 to 30V, which may be too low for some applications.

You can extend a boost regulator's output-voltage range by adding an external transistor that has a higher breakdown voltage than the regulator. However, the internal design of a typical boost regulator's control circuitry often prevents direct drive of an external transistor's base or gate. As an alternative, you can add an external high-voltage transistor by connecting it in a cascode configuration.

Most boost regulators feature a peak-current-control method that reduces the number of external components and thus shrinks the overall pc-board

area of the converter circuit. **Figure 1** shows a boost regulator based on a TPS61040 boost controller, IC_1 , which uses peak-current control.

Applying input voltage V_{IN} to IC_1 's V_{CC} pin and to one leg of inductor L_1 turns on IC_1 's internal MOSFET switch, Q_1 , allowing a gradually increasing amount of current to flow from V_{IN} through L_1 , Q_1 , and internal current-sense resistor R_1 . The circuit's internal controller monitors the volt-

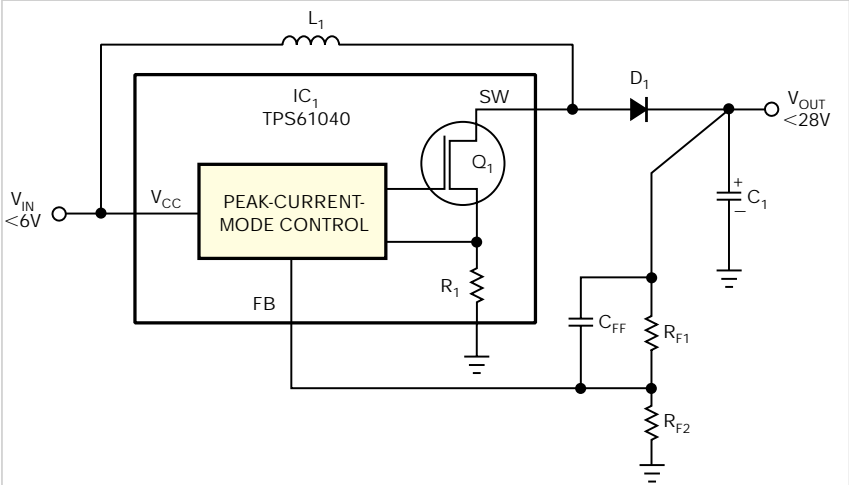


Figure 1 Based on the "barefoot" TPS61040, this dc/dc boost converter delivers output voltages only within IC_1 's ratings.

age across sense resistor R_1 and, upon reaching a predetermined current limit, turns off Q_1 .

Interrupting the current through L_1 raises the voltage across the inductor and applies forward bias to diode D_1 , which conducts and charges output capacitor C_1 to a higher voltage than would be available from the input voltage alone. The input voltage, L_1 's inductance, and the preset peak current through R_1 all affect Q_1 's on-time, and the output voltage sensed by IC_1 's FB (feedback) pin and its external components determines Q_1 's off-time. To maintain operation and set Q_1 's off-time, IC_1 's internal controller must monitor current through L_1 using Q_1 and R_1 .

You can add a higher voltage MOSFET transistor, Q_2 (Figure 2), for applications that require an output voltage higher than the internal transistor's breakdown voltage. To maintain the circuit's current-flow path through L_1 and IC_1 's SW pin, you connect the external transistor in a cascode, or

common-gate, configuration.

Q_2 comprises a low-on-resistance, low-gate-voltage-threshold MOSFET with the addition of diode D_2 between Q_2 's gate and source. To ensure the circuit's proper operation, V_{CC} —5V in this example—must exceed Q_2 's gate-threshold turn-on voltage. In operation, IC_1 's internal control circuit turns on Q_1 , which pulls Q_2 's source close to ground level and turns on Q_2 with almost 5V of gate-to-source potential.

Current flows through inductor L_1 , external transistor Q_2 , internal transistor Q_1 , and sense resistor R_1 , and IC_1 's control circuit "sees" no difference with the installation of Q_2 . Once the inductor current reaches its preset limit, Q_1 turns off, leaving Q_2 with no path for current to flow from its source. The voltage on Q_2 's drain rises rapidly to the desired output voltage plus the voltage drop across D_1 . As the drain voltage rises, Q_2 's drain-to-source capacitance attempts to pull the MOSFET's floating source above 5V, which forward-biases D_2 , connects

IC_1 's SW pin voltage to 5V plus one diode drop, and clamps Q_2 's source to the same voltage.

A boost converter delivers a 180V output at 4 mA (V_{OUT}) to bias a laser circuit from a 9V power supply (V_+). In this application, the 5V input supply need provide only enough current—typically, a few milliamperes—to drive IC_1 's internal logic and the gate of cascode MOSFET Q_2 . You can use a dropping resistor and zener-diode voltage regulator (not shown) to supply the 5V requirement from the 9V supply. You can drive the inductor and IC_1 from a common power supply or from a separate source that's within Q_2 's breakdown-voltage rating. The cascode circuit also can produce any output voltage that's within Q_2 's drain-to-source breakdown-voltage rating. Specify other components with an appropriate voltage rating—for example, breakdown-voltage ratings of inductor L_1 and capacitor C_1 should safely exceed the desired output voltage.EDN

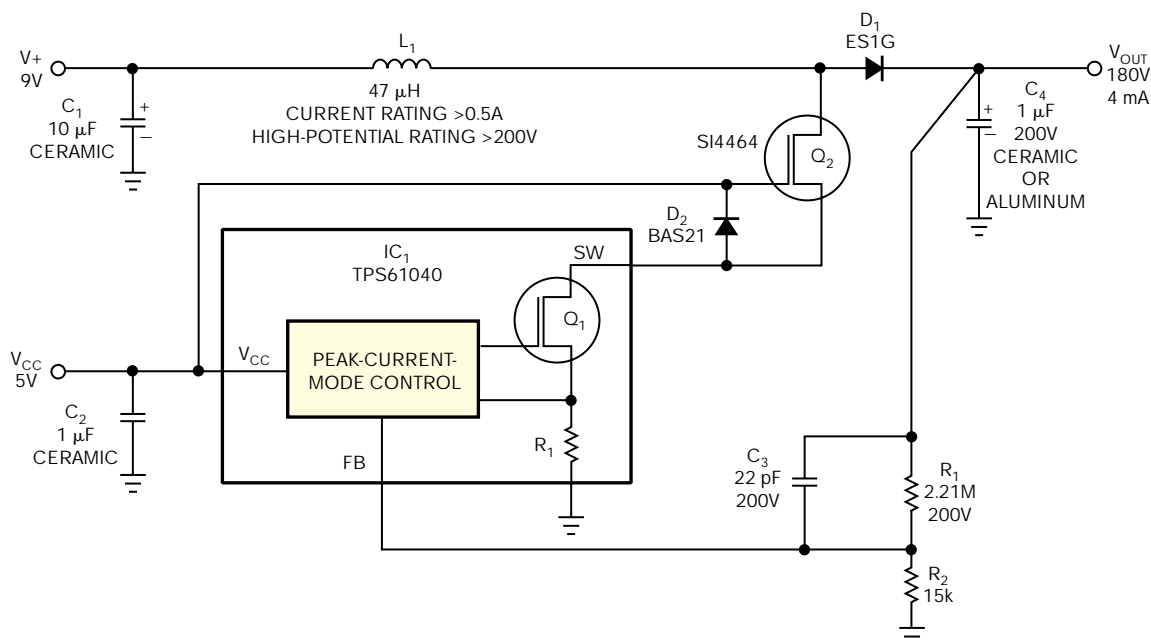


Figure 2 Adding an external cascode-connected MOSFET transistor, Q_2 , with higher breakdown-voltage ratings, enables the circuit to produce higher output voltages.